

<b>Notice of References Cited</b>	Application/Control No. 10/512,068	Applicant(s)/Patent Under Reexamination ABE ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2001/0001932 A1	05-2001	Kobayashi et al.	74/388.0PS
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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